

CHIP COIL (CHIP INDUCTORS) LQG15HS□□□□02D REFERENCE SPECIFICATION

1. Scope

This reference specification applies to LQG15HS_02 series, for Chip Coil (Chip Inductors).

2. Part Numbering
(ex) LQ

LQ G 15 H S 1N0 S 0 2 D

Product ID Structure Dimension Applications (L×W) and Characteristics Category Inductance Characteristics Category Inductance Tolerance Features Electrode D:Taping b:B:BULK

*Bulk packing (B) also available

3. Rating

T T T T T T T T T T T T T T T T T T T	perature Kange	-55°C to	1123 0		ı	1	
Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance (Ω max.)	Self Resonant Frequency (MHz min.)	Rated Current (mA)
					(3¢ 111ax.)	(1711 12 111111.)	(IIIA)
	LQG15HS1N0B02D LQG15HS1N0C02D	1.0				10000	
	LQG15HS1N0S02D	1.0				10000	
	LQG15HS1N1B02D						
		1.1					
	LQG15HS1N1C02D	1.1					
	LQG15HS1N1S02D						
	LQG15HS1N2B02D LQG15HS1N2C02D	1.2					
	LQG15HS1N2S02D	1.2					
					0.07		1000
	LQG15HS1N3B02D LQG15HS1N3C02D	1.3					
	LQG15HS1N3S02D	1.5					
	LQG15HS1N5B02D		1				
	LQG15HS1N5C02D	1.5					
	LQG15HS1N5S02D	1.5					
	LQG15HS1N6B02D						
	LQG15HS1N6C02D	1.6					
	LQG15HS1N6S02D	1.0					
	LQG15HS1N8B02D						
	LQG15HS1N8C02D	1.8			0.08		950
	LQG15HS1N8S02D	1.0	B:±0.1nH		0.00		000
	LQG15HS2N0B02D		C:±0.2nH	8			
	LQG15HS2N0C02D	2.0	S:±0.3nH			6000	
	LQG15HS2N0S02D	2.0				0000	
	LQG15HS2N2B02D				0.09		900
	LQG15HS2N2C02D	2.2					
	LQG15HS2N2S02D						
	LQG15HS2N4B02D		1				
	LQG15HS2N4C02D	2.4			0.11		850
	LQG15HS2N4S02D						
	LQG15HS2N7B02D						
	LQG15HS2N7C02D	2.7			0.12		
	LQG15HS2N7S02D						
	LQG15HS3N0B02D		1				
	LQG15HS3N0C02D	3.0					800
	LQG15HS3N0S02D				0.405		
	LQG15HS3N3B02D]		0.125		
	LQG15HS3N3C02D	3.3					
	LQG15HS3N3S02D						
	LQG15HS3N6B02D						
	LQG15HS3N6C02D	3.6			0.14		750
	LQG15HS3N6S02D						

Customer	MURATA	Inductance		Q	DC	Self Resonant	Rated
Part Number	Part Number	(nH)	Tolerance	(min.)	Resistance	Frequency	Current
T dit Hamber		('''' ')		(111111.)	(Ω max.)	(MHz min.)	(mA)
	LQG15HS3N9B02D						
	LQG15HS3N9C02D	3.9					
	LQG15HS3N9S02D				0.14		750
	LQG15HS4N3B02D						
	LQG15HS4N3C02D	4.3				6000	
	LQG15HS4N3S02D						
	LQG15HS4N7B02D						
	LQG15HS4N7C02D	4.7	B:±0.1nH		0.16		700
	LQG15HS4N7S02D		C:±0.2nH				
	LQG15HS5N1B02D		S:±0.3nH				
	LQG15HS5N1C02D	5.1				5300	
	LQG15HS5N1S02D				0.18		650
	LQG15HS5N6B02D	1					
	LQG15HS5N6C02D	5.6					
	LQG15HS5N6S02D						
	LQG15HS6N2B02D]					
	LQG15HS6N2C02D	6.2			0.20	4500	
	LQG15HS6N2S02D						600
	LQG15HS6N8G02D						000
	LQG15HS6N8H02D	6.8			0.22		
	LQG15HS6N8J02D						
	LQG15HS7N5G02D						
	LQG15HS7N5H02D	7.5				4200	
	LQG15HS7N5J02D				0.24		550
	LQG15HS8N2G02D]			0.24		330
	LQG15HS8N2H02D	8.2				3700	
	LQG15HS8N2J02D			8			
	LQG15HS9N1G02D			O			
	LQG15HS9N1H02D	9.1					
	LQG15HS9N1J02D				0.26	3400	
	LQG15HS10NG02D				0.20	3400	
	LQG15HS10NH02D	10					500
	LQG15HS10NJ02D						
	LQG15HS12NG02D						
	LQG15HS12NH02D	12	0 00/		0.28	3000	
	LQG15HS12NJ02D	<u></u>	G:±2%			<u> </u>	
	LQG15HS15NG02D		H:±3%				
	LQG15HS15NH02D	15	J:±5%		0.32	2500	450
	LQG15HS15NJ02D						
	LQG15HS18NG02D						
	LQG15HS18NH02D	18			0.36	2200	400
	LQG15HS18NJ02D]					
	LQG15HS22NG02D						
	LQG15HS22NH02D	22			0.42	1900	
	LQG15HS22NJ02D	1					
	LQG15HS27NG02D		1				
	LQG15HS27NH02D	27			0.46	1700	350
	LQG15HS27NJ02D	1					
	LQG15HS33NG02D		1				
	LQG15HS33NH02D	33			0.58	1600	
	LQG15HS33NJ02D	1					
	LQG15HS39NG02D		1				
	LQG15HS39NH02D	39			0.65	1200	300
		1 3			0.00	00	
	LQG15HS39NJ02D						

Customer Part Number	MURATA Part Number	Inductance (nH)	Tolerance	Q (min.)	DC Resistance $(\Omega \text{ max.})$	Self Resonant Frequency (MHz min.)	Rated Current (mA)
	LQG15HS47NG02D LQG15HS47NH02D LQG15HS47NJ02D	47			0.72	1000	300
	LQG15HS56NG02D LQG15HS56NH02D LQG15HS56NJ02D	56			0.82	800	250
	LQG15HS68NG02D LQG15HS68NH02D LQG15HS68NJ02D	68			0.92	800	250
	LQG15HS82NG02D LQG15HS82NH02D LQG15HS82NJ02D	82			1.20	700	
	LQG15HSR10G02D LQG15HSR10H02D LQG15HSR10J02D	100	G:±2% H:±3%		1.25		200
	LQG15HSR12G02D LQG15HSR12H02D LQG15HSR12J02D	120	J:±5%	8	1.30	600	
	LQG15HSR15G02D LQG15HSR15H02D LQG15HSR15J02D	150			2.99	550	450
	LQG15HSR18G02D LQG15HSR18H02D LQG15HSR18J02D	180			3.38	500	150
	LQG15HSR22G02D LQG15HSR22H02D LQG15HSR22J02D	220		3.77	450	120	
	LQG15HSR27G02D LQG15HSR27H02D LQG15HSR27J02D	270			4.94	400	110

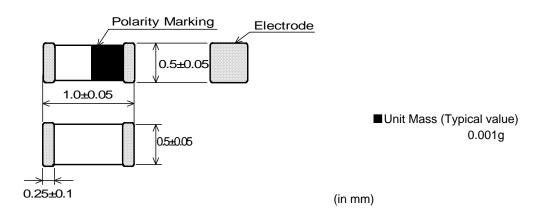
4. Testing Conditions

《Unless otherwise specified》 《In case of doubt》

Temperature : Ordinary Temperature / 15° C to 35° C Temperature : 20° C $\pm 2^{\circ}$ C

Humidity : Ordinary Humidity / 25%(RH) to 85%(RH) Humidity : 60%(RH) to 70%(RH) Atmospheric Pressure : 86kPa to 106 kPa

5. Appearance and Dimensions



6. Electrical Performance

No.	Item	Specification	Test Method
6.1	Inductance	Inductance shall meet item 3.	Measuring Equipment:
6.2	Q	Q shall meet item 3.	Polarity Marking 11.5mm Measuring Method: See P.11 [Electrical Performance:Measuring Method of Inductance/ Q]
6.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment: Digital multi meter
6.4	Self Resonant Frequency (S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: Agilent 8753C or equivalent
6.5	Rated Current	Self temperature rise shall be limited to 25°C max.	The rated current is applied.

7. Mechanical Performance

n <u>ecnai</u>	lical Performance		
No.	Item	Specification	Test Method
7.1	Shear Test	Chip coil shall not be damaged after tested as test method.	Substrate: Glass-epoxy substrate Land 0.5 0.5 (in mm) Force: 5N Hold Duration: 5s±1s Applied Direction: Parallel to PCB Chip Coil Substrate
7.2	Bending Test	Chip coil shall not be damaged after tested as test method.	Substrate: Glass-epoxy substrate (100mm × 40mm × 0.8mm) Speed of Applying Force: 1mm / s Deflection: 2mm Hold Duration: 30s Pressure jig R340 F Deflection A5 Product (in mm)

No.	Item	Specification	Test Method
7.3	Vibration	Appearance: No damage Inductance Change: within ±10%	Oscillation Frequency: 10Hz to 55Hz to 10Hz for 1 min Total Amplitude: 1.5mm
			Testing Time: A period of 2 hours in each of 3 mutually perpendicular directions.
7.4	Solderability	The wetting area of the electrode shall be at least 90% covered with new solder coating.	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C±10°C / 60s to 90s Solder Temperature: 240°C±5°C Immersion Time: 3s±1s
7.5	Resistance to Soldering Heat	Appearance: No damage Inductance Chang e: within ±10%	Flux: Ethanol solution of rosin 25(wt)% (Immersed for 5s to 10s) Solder: Sn-3.0Ag-0.5Cu Pre-Heating: 150°C±10°C / 1 min to 2 min Solder Temperature: 270°C±5°C Immersion Time: 10s±1s Then measured after exposure in the room condition for 24h±2h.

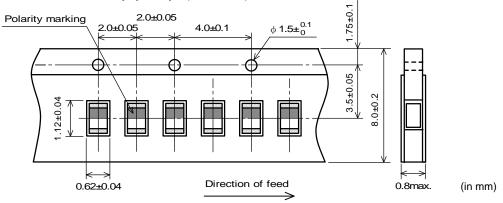
8. Environmental Performance

It shall be soldered on the substrate.

No.	Item	Specification	Test Method
8.1	Humidity	Appearance: No damage Inductance Change: within ±10%	Temperature: 40°C±2°C Humidity: 90%(RH) to 95%(RH) Time: 1000h (+48h,-0h) Then measured after exposure in the room condition for 24h±2h.
8.2	Heat Life		Temperature: 125°C±2°C Current: Rated Current (See the 3.) Time: 1000h (+48h, -0h) Then measured after exposure in the room condition for 24h±2h.
8.3	Humidity Load		Temperature: 40°C±2°C Humidity: 90%(RH) to 95%(RH) Current: Rated Current (See the 3.) Time: 1000h (+48h, -0h) Then measured after exposure in the room condition for 24h±2h.
8.4	Temperature Cycle		1 cycle: 1 step: -55°C (+0°C, -3°C) / 30 min±3 min 2 step: Ordinary temp. / 2 min to 3 min 3 step: +125°C (+3°C, -0°C) / 30 min±3 min 4 step: Ordinary temp. / 2 min to 3 min Total of 10 cycles Then measured after exposure in the room condition for 24h±2h.

9. Specification of Packaging

9.1 Appearance and Dimensions of paper tape (8mm-wide)



9.2 Specification of Taping

(1) Packing quantity (standard quantity)

10,000 pcs. / reel

(2) Packing Method

Products shall be packed in the cavity of the base tape and sealed by top tape and bottom tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Base tape and Top tape has no spliced point.

(5) Missing components number

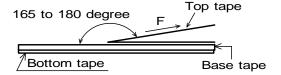
Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

9.3 Pull Strength

Top tape	5N min.
Bottom tape	SIN IIIIII.

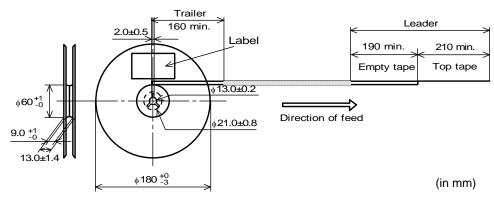
9.4 Peeling off force of cover tape

Speed of Peeling off	300mm / min
Peeling off force	0.1N to 0.6N
	(minimum value is typical)



9.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.



9.6 Marking for reel

Customer part number, MURATA part number, Inspection number (*1), RoHS marking (*2), Quantity etc ···

*1) < Expression of Inspection No.>

$$\frac{\Box\Box}{(1)} \frac{OOOO}{(2)} \frac{\times \times \times}{(3)}$$

- (1) Factory Code
- (2) Date First digit: Year / Last digit of year

Second digit : Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O, N, D

Third, Fourth digit: Day

- (3) Serial No.
- *2) <Expression of RoHS marking >

ROHS –
$$\underline{Y}$$
 ($\underline{\Delta}$)

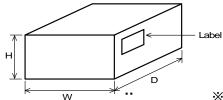
- (1) RoHS regulation conformity parts.
- (2) MURATA classification number

9.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS marking (*2), Quantity, etc ···

Reference

9.8. Specification of Outer Case



Outer Case Dimensions (mm)			Standard Reel Quantity in Outer Case (Reel)
W	D	Н	III Outer Case (Reei)
186	186	93	5

Above Outer Case size is typical. It depends on a quantity of an order.

10. / Caution

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- Power plant control equipment
- (5) Medical equipment
- (6) Transportation equipment (vehicles, trains, ships, etc.)
- (7) Traffic signal equipment
- (8) Disaster prevention / crime prevention equipment
- (9) Data-processing equipment (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

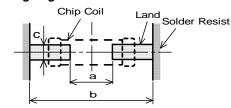
11. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

11.1 Land pattern designing



а	0.4
b	1.4 to 1.5
С	0.5 to 0.6
	(in mn

11.2 Flux, Solder

- ·Use rosin-based flux.
- Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). Don't use water-soluble flux.
- ·Use Sn-3.0Ag-0.5Cu solder.
- •Standard thickness of solder paste : $100 \,\mu$ m to $150 \,\mu$ m.

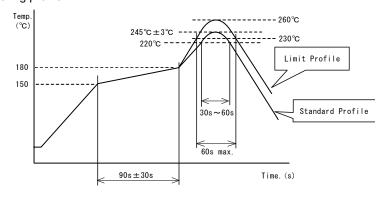


11.3 Reflow soldering conditions

- •Inductance value may be changed a little due to the amount of solder.
 - So, the chip coil shall be soldered by reflow so that the solder volume can be controlled.
- •Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max.
- Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.
- •Standard soldering profile and the limit soldering profile is as follows.

The excessive limit soldering conditions may cause leaching of the electrode and/or resulting in the deterioration of product quality.

·Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C∼180°	C, 90s±30s
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C, 10s
Cycle of reflow	2 times	2 times

11.4 Reworking with soldering iron

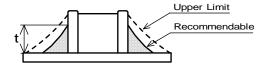
The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C, 1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	ϕ 3mm max.
Soldering time	3(+1, -0)s
Time	2 times

Note: Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

11.5 Solder Volume

- •Solder shall be used not to be exceed the upper limits as shown below.
- •Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance.



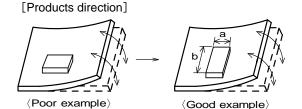
 $1/3T \le t \le T$ T:thickness of product



11.6 Product's location

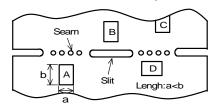
The following shall be considered when designing and laying out P.C.B.'s.

(1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.



Products shall be located in the sideways direction (Length:a<b) to the mechanical stress.

(2) Products location on P.C.B. separation



Products (A, B, C, D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board.

Because they may be subjected the mechanical stress in order of $A > C > B \cong D$.

11.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max. (40°C max for IPA.)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - 1. Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.

11.8 Resin coating

The inductance value may change and/or it may affect on the product's performance due to high cure-stress of resin to be used for coating/molding products. So please pay your careful attention when you select resin. In prior to use, please make the reliability evaluation with the product mounted in your application set.

11.9 Handling of a substrate

After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

Excessive mechanical stress may cause cracking in the product.





11.10 Storage and Handing Requirements

(1) Storage period

Use the products within 6 months after delivered.

Solderability should be checked if this period is exceeded.

(2) Storage conditions

• Products should be stored in the warehouse on the following conditions.

Temperature : -10°C to 40°C

Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity

Don't keep products in corrosive gases such as sulfur, chlorine gas or acid, or it may cause oxidization of electrode, resulting in poor solderability.

- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- Products should be stored under the airtight packaged condition.

(3) Handling Condition

Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

12./\!\ Note

- (1) Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2) You are requested not to use our product deviating from the reference specifications.
- (3) The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

-<Electrical Performance:Measuring Method of Inductance/Q>-

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.

$$Z_{\text{m}} \xrightarrow{V_1} \begin{pmatrix} A & B \\ C & D \end{pmatrix} \xrightarrow{V_2} Z_{X} \qquad \begin{pmatrix} V_1 \\ I_1 \end{pmatrix} = \begin{pmatrix} A & B \\ C & D \end{pmatrix} \begin{pmatrix} V_2 \\ I_2 \end{pmatrix}$$
Test Head Test fixture Product

(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1}$$
 , $Zx = \frac{V_2}{I_2}$

(3) Thus, the relation between Zx and Zm is following;

$$Z = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
$$\beta = B / D = Zsm - (1 - Yom Zsm)Zss$$

$$\Gamma = C / A = Yom$$

Zsm:measured impedance of short chip
Zss:residual impedance of short chip (0nH)
Yom:measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.